PLUS Search Results for S/N 09/975,049, Searched June 07, 2002 (Top 50)

5761120	5278087	5561620	6125059	5467308
5633518	5274263	5598369	5511020	5824584
5894148	5585293	5917215	4412311	5886368
6225167	5587947	5838040	6009033	5969383
6225167	5615147	5897354	6218245	4115914
5422292	5687120	5929478	6218245	4334292
5457061	5689459	6072720	6242306	4870470
5625213	5940325	6137728	4868618	5508543
4868619	4336603	5773862	6075724	5905264
5202850	4894802	6071777	5408115	6011725

Most Frequently Occurring Classifications of Patents Returned From A Search of 09/975,049 on June 07, 2002

Combined Classifications

- 15 257/321
- 11 257/316
- 8 365/185.18
- 8 365/185.3
- 7 365/185.26
- 7 365/185.28
- 6 257/314
- 6 365/185.29
- 5 365/185.33
- 5 438/264
- 4 438/261
- 3 257/324
- 3 365/185.01
- 3 365/185.09
- 3 365/185.12
- 3 365/185.14
- 3 365/185.22
- 3 365/185.27
- 3 438/594
- 2 257/315
- 2 257/319
- 2 257/322
- 2 257/325
- 2 257/326
- 2 257/412
- 2 365/185.05
- 2 365/185.1
- 2 365/185.21
- 2 365/185.24
- 2 365/185.25
- 2 365/185.31
- 2 365/218
- 2 438/257
- 2 438/258
- 2 438/267
- 2 438/275
- 2 438/475
- 2 438/769
- 2 438/775
- 2 438/776
- 2 438/910
- 2 438/911

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15 257/321
                 (4 OR, 11 XR)
         Class
                 257 : ACTIVE SOLID-STATE DEVICES
         257/213
                       FIELD EFFECT DEVICE
         257/288
                       .Having insulated electrode (e.g., MOSFET, MOS
                              diode)
         257/314
                       .. Variable threshold (e.g., floating gate
                             memory device)
         257/315
                       ...With floating gate electrode
         257/316
                       ....With additional contacted control electrode
         257/321
                       .....With thin insulator region for charging or
                          discharging floating electrode by quantum mechanical
                          tunneling
11 257/316
                 (3 OR, 8 XR)
                 257 : ACTIVE SOLID-STATE DEVICES
                       FIELD EFFECT DEVICE
         257/213
         257/288
                       .Having insulated electrode (e.g., MOSFET, MOS
                             diode)
        257/314
                       ..Variable threshold (e.g., floating gate
                            memory device)
         257/315
                       ...With floating gate electrode
         257/316
                       ....With additional contacted control electrode
                (1 OR, 7 XR)
8 365/185.18
                 365 : STATIC INFORMATION STORAGE AND RETRIEVAL
         365/185.01
                      FLOATING GATE
        365/185.18
                      .Particular biasing
8 365/185.3
                 (7 OR, 1 XR)
        Class
                 365 : STATIC INFORMATION STORAGE AND RETRIEVAL
        365/185.01 FLOATING GATE
365/185.18 .Particular biasing
365/185.29 ..Erase
                      ...Over erasure
        365/185.3
                (0 OR, 7 XR)
7 365/185.26
        Class 365: STATIC INFORMATION STORAGE AND RETRIEVAL
        365/185.01 FLOATING GATE 365/185.18 Particular b
                     .Particular biasing
        365/185.18
        365/185.26
                     .. Floating electrode (e.g., source, control
                          gate, drain)
7 365/185.28
                 (4 OR, 3 XR)
        Class
                 365 : STATIC INFORMATION STORAGE AND RETRIEVAL
        365/185.01
                     FLOATING GATE
                     .Particular biasing
        365/185.18
        365/185.28 .. Tunnel programming
6 257/314
                 (4 OR, 2 XR)
        Class 257: ACTIVE SOLID-STATE DEVICES
        257/213
                     FIELD EFFECT DEVICE
        257/288
                      .Having insulated electrode (e.g., MOSFET, MOS
                           diode)
        257/314
                       .. Variable threshold (e.g., floating gate
                          memory device)
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6 365/185.29
                  (1 OR, 5 XR)
         Class 365: STATIC INFORMATION STORAGE AND RETRIEVAL
         365/185.01 FLOATING GATE
365/185.18 .Particular biasing
365/185.29 ..Erase
 5 365/185.33 (1 OR, 4 XR)
          Class 365 : STATIC INFORMATION STORAGE AND RETRIEVAL
          365/185.01 FLOATING GATE
          365/185.18 .Particular biasing
                      ..Erase
          365/185.29
          365/185.33
                       ...Flash
                 (1 OR, 4 XR)
 5 438/264
          Class 438: SEMICONDUCTOR DEVICE MANUFACTURING: PROCESS
                        MAKING FIELD EFFECT DEVICE HAVING PAIR OF
          438/142
                             ACTIVE REGIONS SEPARATED BY GATE STRUCTURE BY
FORMATION OR ALTERATION OF SEMICONDUCTIVE ACTIVE REGIONS
                        .Having insulated gate (e.g., IGFET, MISFET,
          438/197
                             MOSFET, etc.)
                        .. Having additional gate electrode surrounded
          438/257
                            by dielectric (i.e., floating gate)
                        ...Tunneling insulator
          438/264
                  (3 OR, 1 XR)
  4 438/261
                  438 : SEMICONDUCTOR DEVICE MANUFACTURING: PROCESS
          Class
                        MAKING FIELD EFFECT DEVICE HAVING PAIR OF
          438/142
                              ACTIVE REGIONS SEPARATED BY GATE STRUCTURE BY
FORMATION OR ALTERATION OF SEMICONDUCTIVE ACTIVE REGIONS
                        .Having insulated gate (e.g., IGFET, MISFET,
          438/197
                             MOSFET, etc.)
                        .. Having additional gate electrode surrounded
          438/257
                            by dielectric (i.e., floating gate)
                        ... Multiple interelectrode dielectrics or
          438/261
                           nonsilicon compound gate insulator
                  (2 OR, 1 XR)
  3 257/324
          Class 257: ACTIVE SOLID-STATE DEVICES
                        FIELD EFFECT DEVICE
          257/213
                        .Having insulated electrode (e.g., MOSFET, MOS
          257/288
                             diode)
                        .. Variable threshold (e.g., floating gate
          257/314
                            memory device)
                        ... Multiple insulator layers (e.g., MNOS
          257/324
                           structure)
                  (2 OR, 1 XR)
  3 365/185.01
                  365 : STATIC INFORMATION STORAGE AND RETRIEVAL
          Class
          365/185.01 FLOATING GATE
  3 365/185.09
                  (0 OR, 3 XR)
          Class 365: STATIC INFORMATION STORAGE AND RETRIEVAL
          365/185.01 FLOATING GATE
365/185.05 .Particular connection
365/185.09 ..Error correction (e.g., redundancy,
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